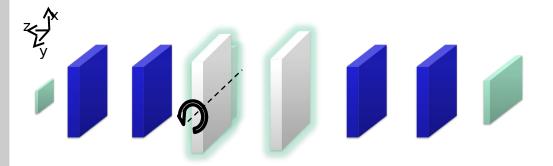
## **DEPFET TB summary**

**DEPFET SuperBelle meeting – July 21st 2009** 

**Marcel Vos, IFIC Valencia** 



# Test Beam Setup





### 4 Telescope planes:

- 32x24µm²
- Common Clear Gate
- 128 x 64 pixels
- 450 μm thick

#### 3 DUTs:

- 24X24µm²
- Capacitative coupled clear gate
- •128 x 64 pixels
- 450 μm thick



### TB2008: programme

- ☐ Voltage scans: Cross-check, we're running in optimal settings
  - $\triangleright$  V<sub>Bias</sub> to the waffer 150-220V
  - $\triangleright V_{\text{Edge}}$
- ☐ Angular scan: To study resolution vs. Cluster size
  - **>** -5, -4, -3, -2, -1.5, -1, -0.5, 0, 0.5, 1, 1.5, 2, 3, 4, 5, 6, 9, 12, 18, 36
- **Beam energy scan:** To analyse wheter the separation "multi-scattering-intrinsic resolution" is performed correctly
  - > 20, 40, 60, 80, 120 GeV
- **□** Large statistics:

3.5 TB of data

- Charge collection uniformity studies
- ➤ In-pixel studies

20 Million events

# Enormous amount of good-quality\* data

(\*) Every 16<sup>th</sup> event is corrupted (understood DAQ problem, solved). CCCG module

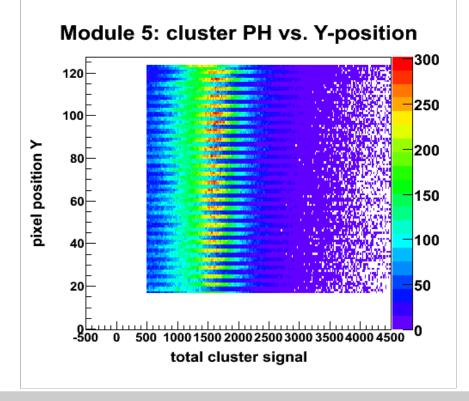


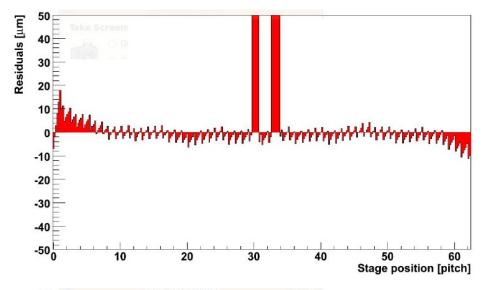
### Experience 2008 in a nutshell

#### Gain variations.

- Not random: there is a definite row modulo 4 structure, but the behaviour is still too irregular to correct using a simple row-wise correction factor.
- Observed initially and very clearly in one telescope module, but present to some level in all modules, including small-pixel DUT (and 2009 S3b modules?)
- Variations of the strength of the effect with time have been observed
- Not understood: looking for a voltage that is distributed to groups of four rows
- Distorts position measurement to a measurable level and must be corrected for

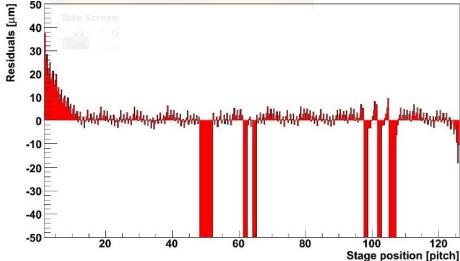
Strong (10 % and more) variations in the signal gain are observed in some modules (module 4). In some other modules (telescope 1, 2, 5 and the DUT) and runs (1262) the effect is at the 1 % level or less.





Edge effect, observed in laser scans, confirmed by test beam data. Variations of V\_edge have no visible effect.

Estimate effect on 50  $\mu$ m sensor.



Edge effect (measurement in last few pixels is significantly biased)



### TB2008: write-up

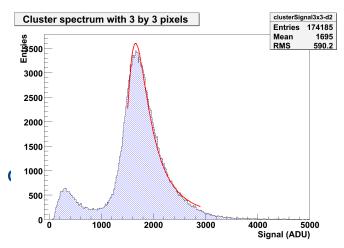
#### **TB2008:**

Results I: charge collection (depend only on clustering)

Material to be provided by Valencia + others

• g<sub>q</sub>, S/N

Compare to lab measurements g\_q measurements repeatible to ~10



CAVEAT: expect better gain results in 2009

Peter Fischer@Ringberg: compare shape to GEANT4 prediction. Tail is indeed depleted. Single pixel response saturates at 4000 ADC. The small-pixel DUT seems to saturate earlier: at ~2000 ADC

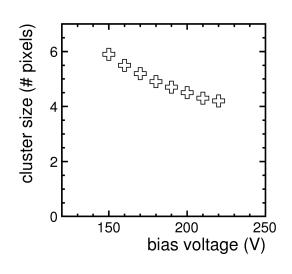


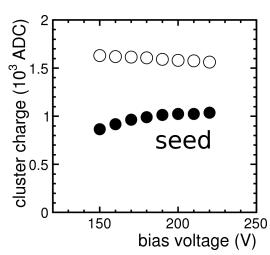


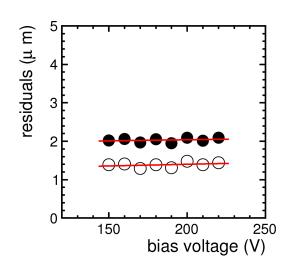
## TB2008: charge collection

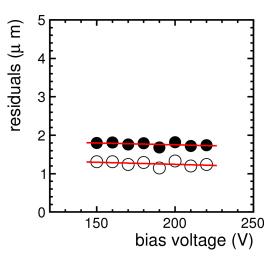
Scanning the sensor bias voltage from 150 to 220 V reveals a strong effect on the lateral dispersion of the signal (#pixels with signal > 2.5 sigma, fraction of charge in the seed pixel). The spatial resolution is only mildly affected.

resolution residuals













## TB2008: charge collection

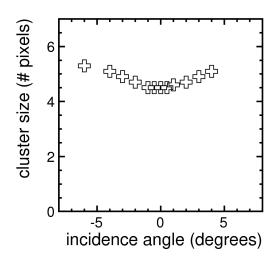
Rotating the small-pixel **DUT** through small angles (-5°,5°) the cluster size and seed fraction reflect the increased charge sharing under nonperpendicular incidence. The resolution of the Xcoordinate improves slightly for 1-3° angles. The resolution shows a strong deterioration beyond 4°.

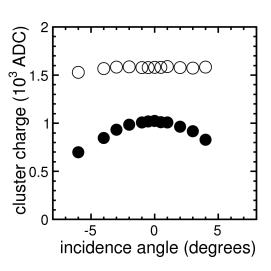


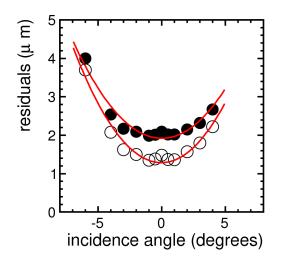
resolution

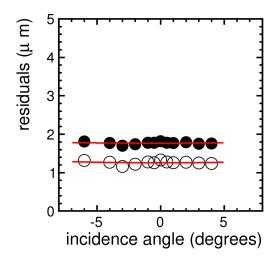


residuals













### **Results II: resolution** (multiple scattering, telescope)

We cannot ignore multiple scattering (even at 120 GeV) or telescope resolution. DUT resolution measurement obtained by plugging in a theoretical expectation for the Multiple Coulomb scattering (either by simulating the setup in GEANT4 or by a fit like P. Kvasnicka).

module	0	1	2	3	4	5
PRG residual	2.8	2.1	2.1	2.0	3.0	3.4
PRG resolution	2.0	1.5	1.7	1.4	2.5	2.5

Energy scan is a useful x-check to see we disentangle intrinsic resolution correctly. First attempt failed.

Not much progress in extrapolation to BELLE-II and ILC

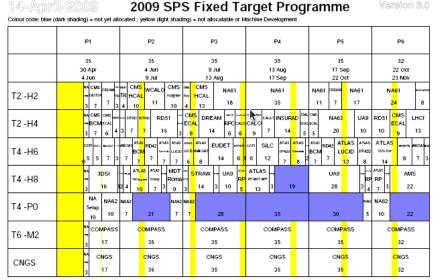


### **TB2009**

http://spsschedule.web.cern.ch/SPSschedule/schedules/sps/2009/v300/all.pdf

#### This summer's TB programme:

- main user's period in second week of August
- EUDET (including DEPFET DUT) starts two weeks earlier
  Setup of DEPFET telescope from 23<sup>rd</sup> of july, to be in the beam by end of July. Some TB team members have arrived at CERN yesterday!



SPS/PS-Coordinator: Horst Breuker E-mail: SPS.Coordinator@cern.ch phone: 73777 (ext. +41 22 767 3777) mobile: 164212 (ext. +41 76 487 4212)

Shift and Compress Schedule by 1 week w.r.t V1.0

#### SPS H6 schedule

Date	23/7 - 6/8	6/8 - 13/8	13/8 - 19/8
Main user	EUDET	DEPFET	LCFI
Parasitic/DUT	DEPFET	?	DEPFET?



### **TB2009**

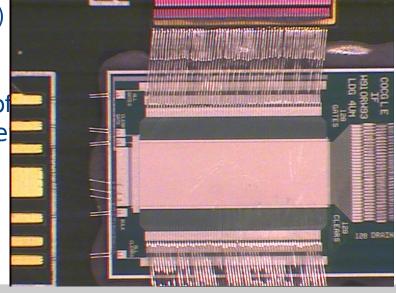
New "telescope" succesfully built

- 128x128 pixel PXD5 matrices
- S3b system, the new work-horse module (Bonn, including tutorial)
- Standard power supplies (connected to modules with a single cable)
- Centralized characterization at MPI Jelena + visiting experts

#### **DUTs**:

- Irradiated module will not be tested (matrix died)
- CCCG module (SB default). First two modules are behaving badly (noisy pixels, hot spots). A third should be bonded in Bonn this week.
- Smaller pixel size (20x20 μm²)
- Shorter gate length (technology problem)

http://aldebaran.hll.mpg.de/twiki/bin/view/Depf http://aldebaran.hll.mpg.de/twiki/bin/vie





### presentations/note

IEEE talk assigned (to Laci)

Some possibilities, combined test beams, TB in magnetic field, etc., will be discussed in a TB workshop at LAL, 3<sup>rd</sup> - 6<sup>th</sup> of November

As silicon tracking/vertexing representative in the scientific committee I should collect ideas in this community and find candidate speakers

